



5208-053-20X CONT

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF: :  
CRAIG B. PRATER ET AL : GROUP: 2212  
SERIAL NO: 08/416,100 : EXAMINER: D. LARKIN  
FILED: APRIL 4, 1995 :  
FOR: ATOMIC FORCE MICROSCOPE  
AND METHOD OF OPERATING  
AN ATOMIC FORCE MICROSCOPE

AMENDMENT

ASSISTANT COMMISSIONER OF PATENTS  
WASHINGTON, DC 20231

SIR:

In response to the Official Office Action dated July  
20, 1995, please amend the above-identified patent application  
as follows:

IN THE TITLE

Page 1, lines 2 and 3, delete the existing title and  
substitute therefor --SCANNING STYLUS ATOMIC FORCE MICROSCOPE  
WITH CANTILEVER TRACKING AND OPTICAL ACCESS--.

IN THE SPECIFICATION

Page 2, line 17, after "07/926,175" insert --, now

U.S. Patent No. 5,412,980--;

line 23, change "53(12), Sep. 19, 1988" to  
--65(1), Jan. 1, 1989--

Page 4, line 13, change "Mayer" to --Meyer--;

line 15, change "(1989)" to --(1991)--.

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